

L Number	Hits	Search Text	DB	Time stamp
1	8	382/150.ccls. and ((measur\$4 or determin\$7) near2 (height\$1) with (solder\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:33
2	0	382/150.ccls. and ((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) with (plat\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:34
3	7223	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) with (plat\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:36
4	0	382/141.ccls. and (382/150.ccls. and ((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) with (plat\$3)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:34
5	3	382/141.ccls. and (((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) with (plat\$3)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:34
6	3357	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) near2 (plat\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:36
7	81	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) near2 (plat\$3)) and (image near process\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:48
8	1	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) near2 (plat\$3)) same (inspect\$5) same (image\$1 imaging)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 15:09
9	49	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) near2 (plat\$3)) same (inspect\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 14:50
28	4	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6) near2 (plat\$3)) same (inspect\$5) same (image\$1 imaging ccd camera\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 15:24
29	221	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6)) same (inspect\$5) same (image\$1 imaging ccd camera\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 15:13
30	2	5450205.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 15:13
63	9	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6)) and 382/150.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 15:28
64	7	((measur\$4 or determin\$7 or detect\$5) near2 (thick\$6)) and 382/150.ccls.) and height\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 15:28

67	1655	((detect\$3 determin\$6 measur\$6) near2 (thick\$4 width\$1) near2 plate\$1)	USPAT	2004/10/12 16:04
68	4	((detect\$3 determin\$6 measur\$6) near2 (thick\$4 width\$1) near2 plate\$1) with (camera\$1 or ccd\$1))	USPAT	2004/10/12 17:01
73	75	382/146.ccls.	USPAT	2004/10/12 17:11
74	2138	356/237.1.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:21
75	5152	inspect\$4 near4 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or anode\$1 or cathode\$1 or cell\$1 or (secondary near cell\$1) or (fuel near cell\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:21
76	1277	inspect\$4 near4 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:21
77	1047	inspect\$4 near3 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:22
78	42	(inspect\$4 near2 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))) and (camera)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:22
79	0	"411073948"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:22

80	50	("4264343" "5874774" "4265641" "4326951" "4361845" "4505724" "4519818" "4541847" "4572879" "4594300" "4604112" "4869736" "4968330" "5009677" "5290343" "5339043" "5348571" "6071636" "3678653" "3898060" "3831351" "4053695" "4058377" "4175165" "4119772" "4124359" "4126434" "4247376" "4276056" "4289504" "4313741" "4314009" "4318152" "4322659" "4332597" "4349359" "4351648" "4364752" "4382226" "4381927" "4431434" "4440552" "4441897" "4455155" "4461953" "4466198" "4469947" "4511237" "4521229" "4547129").pn.	USPAT	2004/10/12 17:23
81	517	382/141.ccls.	USPAT	2004/10/12 17:24
82	1	20020076094.pn.	USPAT;	2004/10/12 17:24
83	2	20020076094.pn.	US-PGPUB; USPAT;	2004/10/12 17:24
84	1	2002-626373.NRAN.	DERWENT;	2004/10/12 17:24
85	230	382/152.ccls.	IBM TDB USPAT;	2004/10/12 17:24
86	142	348/86.ccls.	US-PGPUB; EPO; JPO; DERWENT; IBM TDB USPAT;	2004/10/12 17:24

87	55	382/143.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
88	726	inspect\$4 near2 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
89	165	356/237.1.cccls. and ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or anode\$1 or cathode\$1 or cell\$1 or (secondary near cell\$1) or (fuel near cell\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
90	10	(inspect\$4 near2 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))) and (image near process\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
91	63	(inspect\$4 near2 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))) and (image\$1 or imag\$3 or ccd\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
92	49	(inspect\$4 near2 ((electrode\$1 near plat\$4) or batter\$4 or (power near plate\$1) or (secondary near cell\$1) or (fuel near cell\$1))) and (camera\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
93	2	"11073948"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
94	1	1999-250478.NRAN.	DERWENT	2004/10/12 17:24
95	82	382/150.cccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24
96	3	382/150.cccls. and (((measur\$4 or determin\$7) near2 (height\$1) with (solder\$3)) same (referenc\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/10/12 17:24